TP65H300G4LSGB

650V SuperGaN® GaN FET in PQFN (source tab)

Description

The TP65H300G4LSGB 650V, 240mΩ Gallium Nitride (GaN) FET is a normally-off device using Renesas's Gen IV platform. It combines a state-of-the-art high voltage GaN HEMT with a low voltage silicon MOSFET to offer superior reliability and performance.

The Gen IV SuperGaN® platform uses advanced epi and patented design technologies to simplify manufacturability while improving efficiency over silicon via lower gate charge, output capacitance, crossover loss, and reverse recovery charge.

Related Literature

- Printed Circuit Board Layout and Probing
- Recommendations for Vapor Phase Reflow
- Recommended External Circuitry for GaN FETs
- PQFN Tape and Reel Information

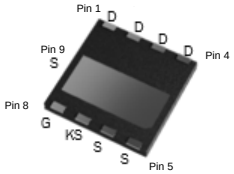
Product Series and Ordering Information

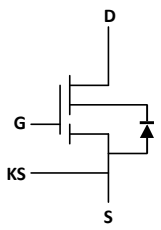
Part Number	Package	Package Configuration
TP65H300G4LSGB-TR*	8x8 PQFN	Source

* "-TR" suffix refers to tape and reel. Refer to AN0012 for details.

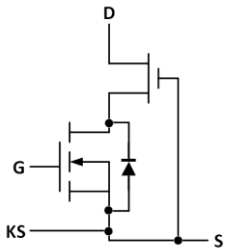
TP65H300G4LSGB
PQFN

(bottom view)





Cascode Schematic Symbol



Cascode Device Structure

Features

- Gen IV technology
- JEDEC-qualified GaN technology
- Dynamic $R_{DS(on)eff}$ production tested
- Robust design, defined by
  - — Wide gate safety margin
  - — Transient over-voltage capability
- Very low Q_{RR}
- Reduced crossover loss
- RoHS compliant and Halogen-free packaging

Benefits

- Achieves increased efficiency in both hard- and soft-switched circuits
  - — Increased power density
  - — Reduced system size and weight
  - — Overall lower system cost
- Easy to drive with commonly-used gate drivers
- GSD pin layout improves high speed design

Applications

- Consumer
- Power adapters
- Low power SMPS
- Lighting

Key Specifications	
V_{DS} (V) min	650
$V_{DSS(TR)}$ (V) max	800
$R_{DS(on)}$ (mΩ) max*	312
Q_{RR} (nC) typ	23
Q_G (nC) typ	9.6

* Dynamic $R_{DS(on)}$; see Figures 18 and 19

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Absolute Maximum Ratings (T_c=25°C unless otherwise stated.)

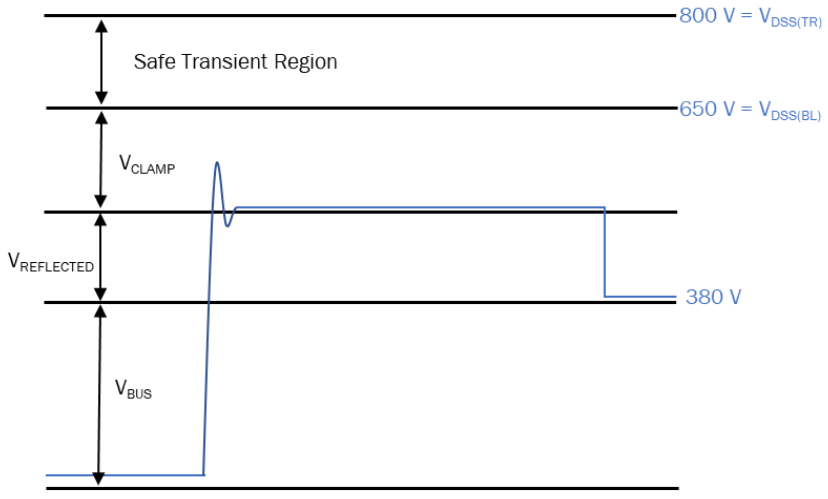
Symbol	Parameter		Limit Value	Unit
V_{DSS}	Drain to source voltage (T_J = -55°C to 150°C)		650	V
$V_{DSS(TR)}$	Transient drain to source voltage [a]		800	
V_{GSS}	Gate to source voltage		±10	
P_D	Maximum power dissipation @T_C=25°C		21	W
I_D	Continuous drain current @T_C=25°C [b]		6.5	A
	Continuous drain current @T_C=100°C [b]		4.1	A
I_{DM}	Pulsed drain current (pulse width: 10µs)		30	A
T_C	Operating temperature	Case	-55 to +150	°C
T_J		Junction	-55 to +150	°C
T_S	Storage temperature		-55 to +150	°C
T_{SOLD}	Reflow soldering temperature [c]		260	°C

Notes:

a. In off-state, spike duration < 30µs, Non-repetitive

b. For increased stability at high current operation, see Circuit Implementation on page 3

c. Reflow MSL3



Primary Switch Voltage Stress (264 V AC)

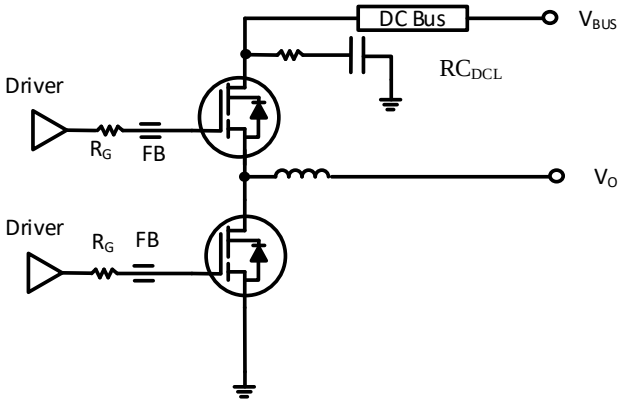
Thermal Resistance

Symbol	Parameter	Typical	Unit
$R_{\Theta JC}$	Junction-to-case	5.5	°C/W
$R_{\Theta JA}$	Junction-to-ambient [d]	50	°C/W

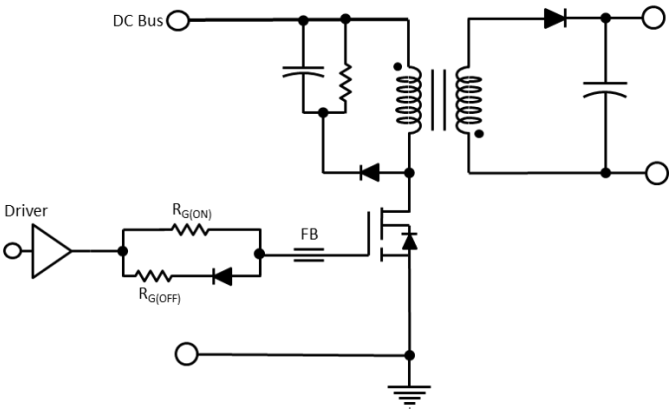
Notes:

d. Device on one layer epoxy PCB for drain connection (vertical and without air stream cooling, with 6cm² copper area and 70µm thickness)

Circuit Implementation



Simplified Half-bridge Schematic



Simplified Single Ended Schematic

Recommended gate drive: (0V, 6V) with $R_{G(tot)}$ = 45 –50 Ω[a]

For additional driver configurations/options please see application note AN0009.

Recommended gate drive:

Gate drive: (0V, 6V): $R_{G(ON)}$ = 50 to 150 Ω; $R_{G(OFF)}$ = 0 to 10 Ω
Gate drive*: (-6V, 6V): $R_{G(ON)}$ = 50 to 100 Ω; $R_{G(OFF)}$ = 0 to 20 Ω

*Drop-in with discrete e-mode gate drive that level shifts any standard silicon MOSFET controller with integrated driver (i.e. NCP1342)

Gate Ferrite Bead (FB)	Required DC Link RC Snubber (RC_{DCL}) [b]
240Ω @ 100MHz	4.7—10nF + 3.3Ω

Notes:

a. For bridge topologies only. R_G could be much smaller in single ended topologies.

b. RC_{DCL} should be placed as close as possible to the drain pin.

Electrical Parameters (T_J=25°C unless otherwise stated)

Symbol	Parameter	Min	Typ	Max	Unit	Test Conditions
Forward Device Characteristics						
$V_{DSS(BL)}$	Maximum drain-source voltage	650	—	—	V	V_{GS}=0V
$V_{GS(th)}$	Gate threshold voltage	2	2.4	2.8	V	V_{DS}=V_{GS}, I_D=0.5mA
$\Delta V_{GS(th)}/T_J$	Gate threshold voltage temperature coefficient	—	-5.8	—	mV/°C	
$R_{DS(on)eff}$	Drain-source on-resistance [a]	—	240	312	mΩ	V_{GS}=6V, I_D=6.5A, T_J=25°C
		—	492	—		V_{GS}=6V, I_D=6.5A, T_J=150°C
I_{DSS}	Drain-to-source leakage current	—	1.2	12	μA	V_{DS}=650V, V_{GS}=0V, T_J=25°C
		—	8	—		V_{DS}=650V, V_{GS}=0V, T_J=150°C
I_{GSS}	Gate-to-source forward leakage current	—	—	100	nA	V_{GS}=12V
	Gate-to-source reverse leakage current	—	—	-100		V_{GS}=-12V
C_{ISS}	Input capacitance	—	414	—	pF	V_{GS}=0V, V_{DS}=400V, *f*=1MHz
C_{OSS}	Output capacitance	—	16	—		
C_{RSS}	Reverse transfer capacitance	—	1	—		
$C_{O(er)}$	Output capacitance, energy related [b]	—	24	—	pF	V_{GS}=0V, V_{DS}=0V to 400V
$C_{O(tr)}$	Output capacitance, time related [c]	—	47	—		
Q_G	Total gate charge	—	4.5	—	nC	V_{DS}=400V, V_{GS}=0V to 10V, I_D=6.5A
Q_{GS}	Gate-source charge	—	1.5	—		
Q_{GD}	Gate-drain charge	—	0.6	—		
Q_{OSS}	Output charge	—	19	—	nC	V_{GS}=0V, V_{DS}=0V to 400V
$t_{D(on)}$	Turn-on delay	—	33.6	—	ns	V_{DS}=400V, V_{GS}=0V to 6V, I_D=6.5A, R_G=65Ω, Z_{FB}=330Ω at 100MHz (See Figure 14)
t_R	Rise time	—	4.4	—		
$t_{D(off)}$	Turn-off delay	—	20	—		
t_F	Fall time	—	3.6	—		

Notes:

a. Dynamic $R_{DS(on)}$ value; see Figures 18 and 19 for conditions

b. Equivalent capacitance to give same stored energy from 0V to 400V

c. Equivalent capacitance to give same charging time from 0V to 400V

Electrical Parameters (T_J=25°C unless otherwise stated)

Symbol	Parameter	Min	Typ	Max	Unit	Test Conditions
Reverse Device Characteristics						
I_S	Reverse current	—	—	3.7	A	V_{GS}=0V, T_C=100°C, ≤20% duty cycle
V_{SD}	Reverse voltage [a]	—	1.7	—	V	V_{GS}=0V, I_S=8.5A
		—	1.2	—		V_{GS}=0V, I_S=4.5A
t_{RR}	Reverse recovery time	—	16	—	ns	I_S=10A, V_{DD}=400V, di/dt=1000A/ms
Q_{RR}	Reverse recovery charge	—	23	—	nC	

Notes:

a. Includes dynamic $R_{DS(on)}$ effect

Typical Characteristics (T_c=25 °C unless otherwise stated)

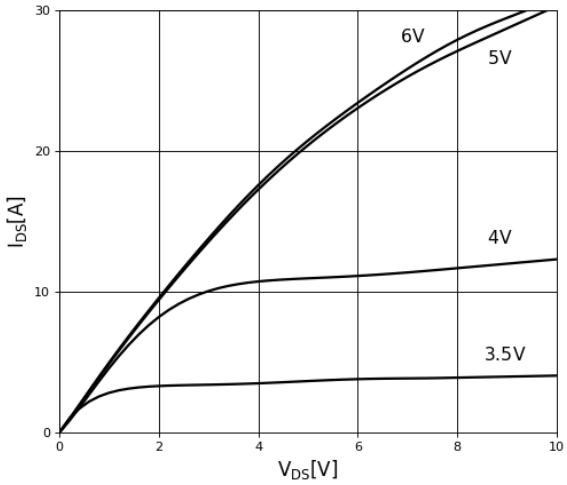


Figure 1. Typical Output Characteristics T_J=25 °C
Parameter: V_{GS}

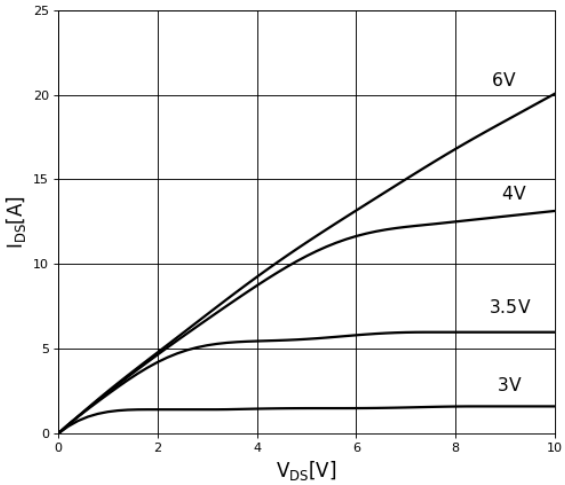


Figure 2. Typical Output Characteristics T_J=150 °C
Parameter: V_{GS}

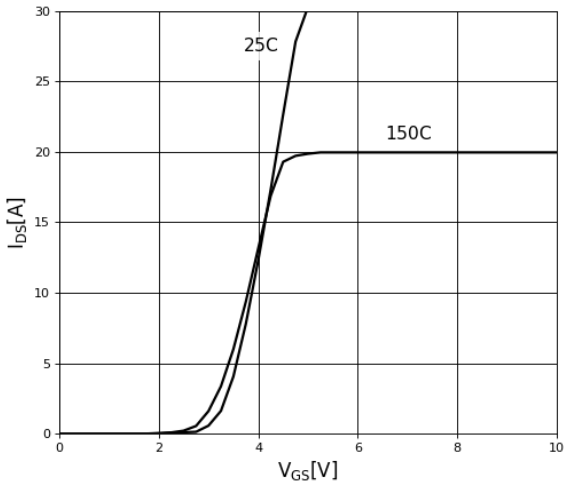


Figure 3. Typical Transfer Characteristics
V_{DS}=10V, parameter: T_J

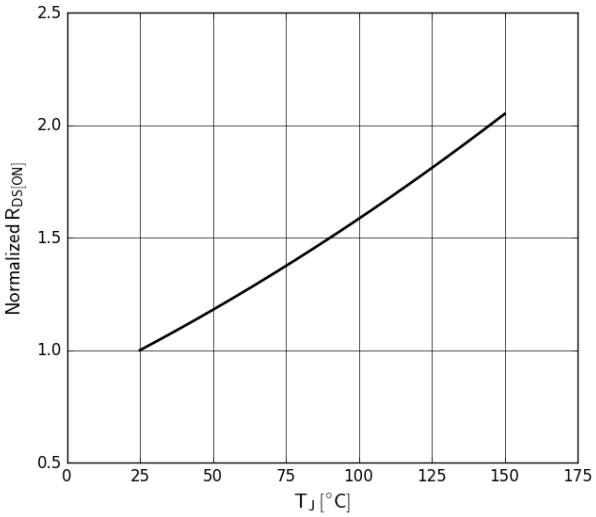


Figure 4. Normalized On-resistance
I_D=16A, V_{GS}=10V

Typical Characteristics (T_c=25 °C unless otherwise stated)

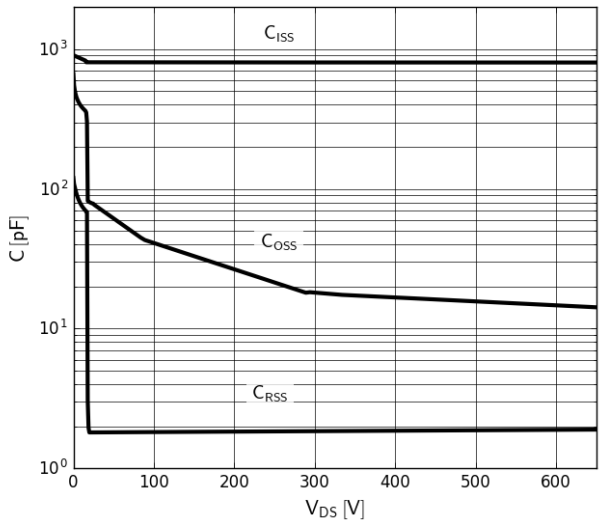


Figure 5. Typical Capacitance

V_{GS}=0V, f=1MHz

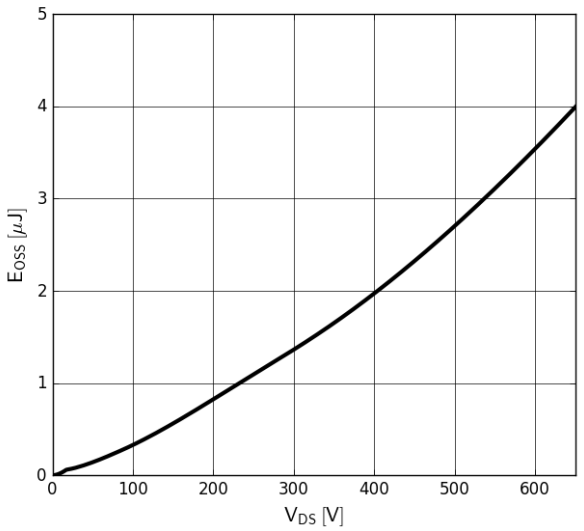


Figure 6. Typical C_{OSS} Stored Energy

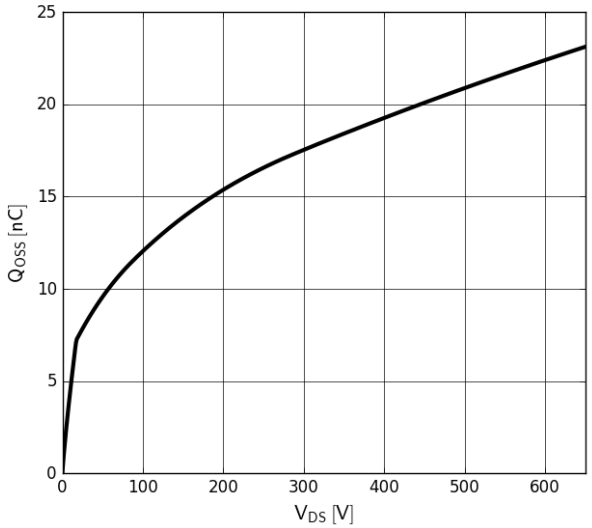


Figure 7. Typical Q_{OSS}

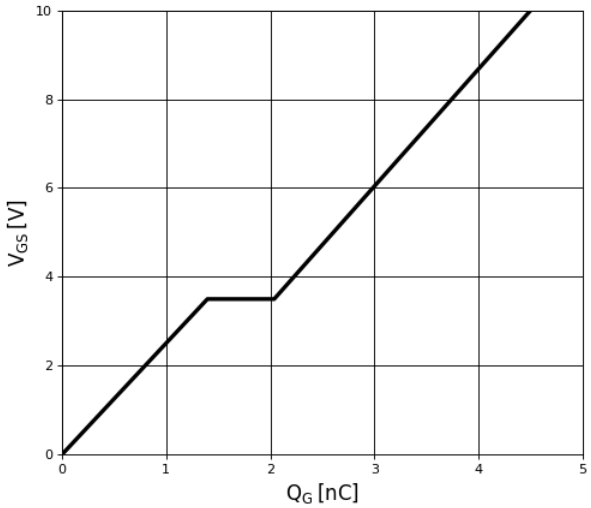


Figure 8. Typical Gate Charge

I_{DS}=10A, V_{DS}=400V

Typical Characteristics (T_c=25 °C unless otherwise stated)

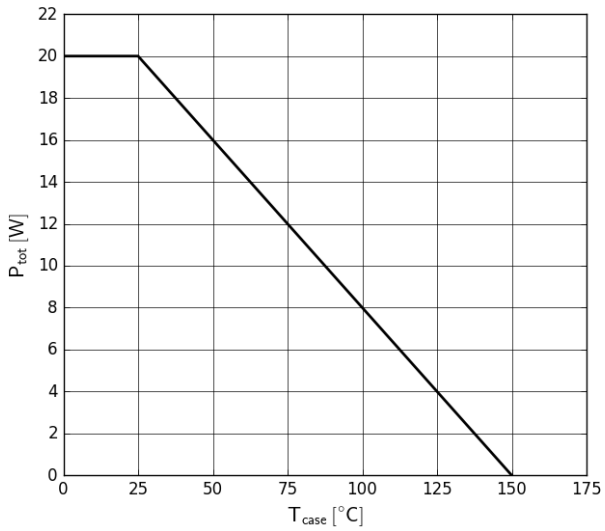


Figure 9. Power Dissipation

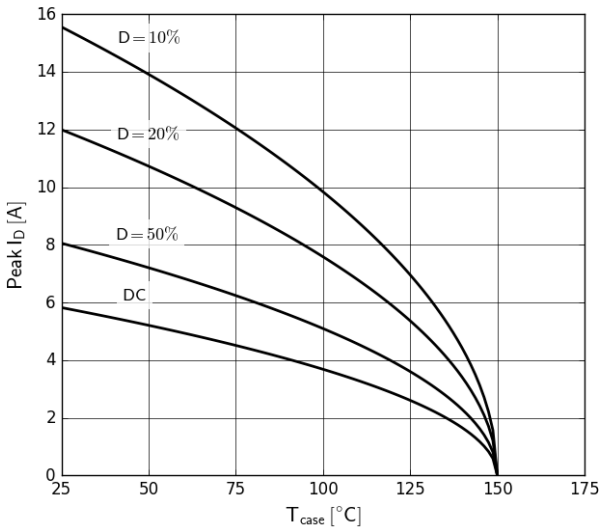


Figure 10. Current Derating

Pulse width ≤ 10µs, V_{GS} ≥ 10V

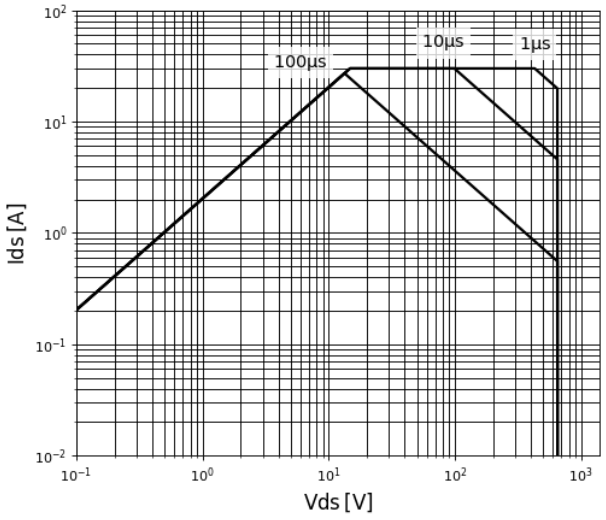


Figure 11. Forward Characteristics of Rev. Diode

I_S=f(V_{SD}), parameter: T_J

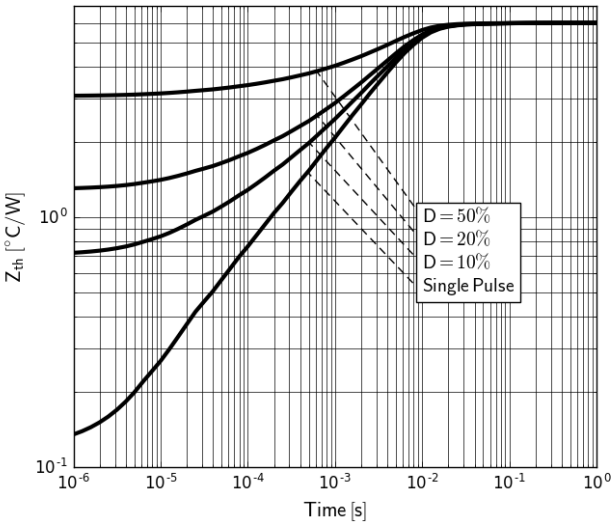


Figure 12. Transient Thermal Resistance

Typical Characteristics (T_c=25 °C unless otherwise stated)

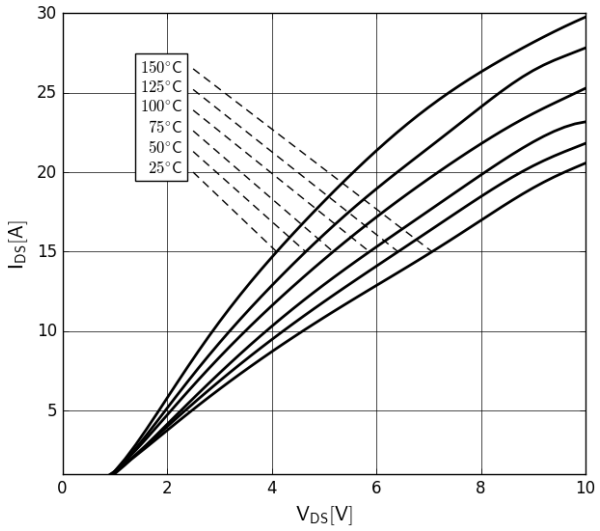


Figure 13. Safe Operating Area TC=25°C

Test Circuits and Waveforms

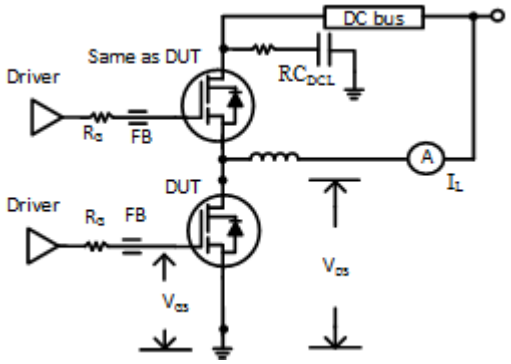


Figure 14. Switching Time Test Circuit

(see circuit implementation on page 3 for methods to ensure clean switching)

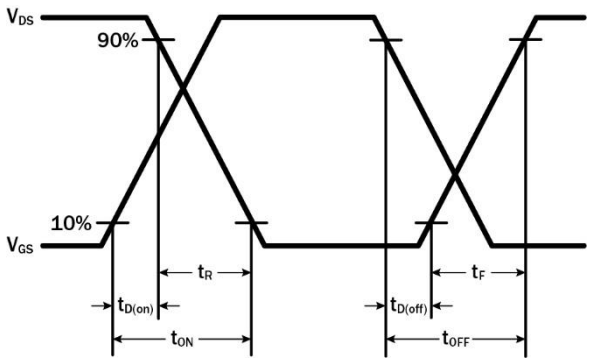


Figure 15. Switching Time Waveform

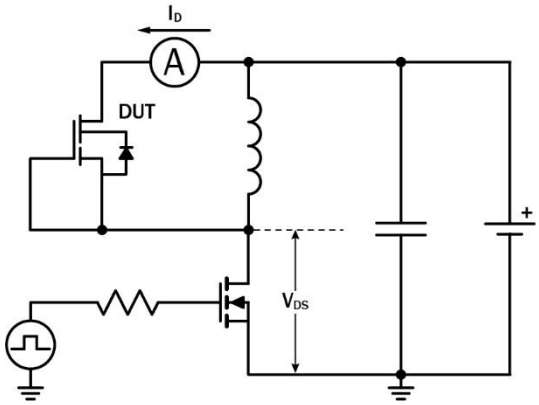


Figure 16. Diode Characteristics Test Circuit

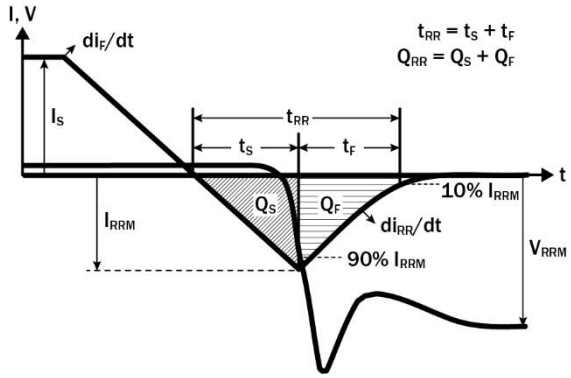


Figure 17. Diode Recovery Waveform

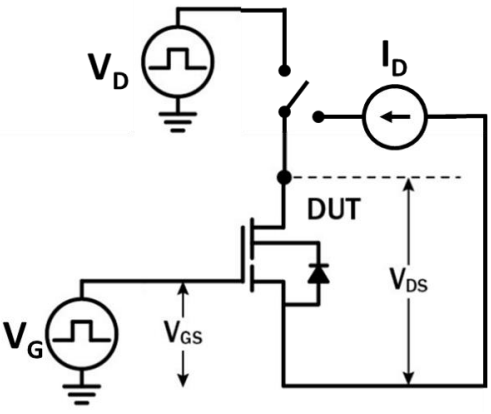


Figure 18. Dynamic $R_{DS(on)eff}$ Test Circuit

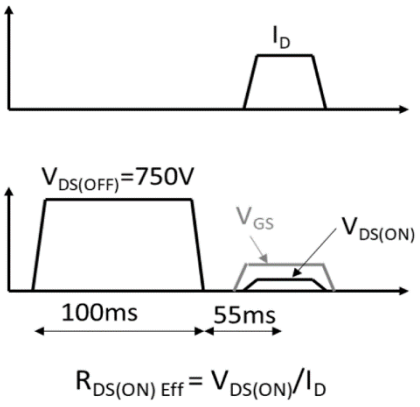


Figure 19. Dynamic $R_{DS(on)eff}$ Waveform

Design Considerations

The fast switching of GaN devices reduces current-voltage crossover losses and enables high frequency operation while simultaneously achieving high efficiency. However, taking full advantage of the fast switching characteristics of GaN switches requires adherence to specific PCB layout guidelines and probing techniques.

Before evaluating Renesas GaN devices, see application note Printed Circuit Board Layout and Probing for GaN Power Switches. The table below provides some practical rules that should be followed during the evaluation.

When Evaluating Renesas GaN Devices:

DO	DO NOT
Minimize circuit inductance by keeping traces short, both in the drive and power loop	Twist the pins of TO-220 or TO-247 to accommodate GDS board layout
Minimize lead length of TO-220 and TO-247 package when mounting to the PCB	Use long traces in drive circuit, long lead length of the devices
Use shortest sense loop for probing; attach the probe and its ground connection directly to the test points	Use differential mode probe or probe ground clip with long wire
See Printed Circuit Board Layout and Probing	

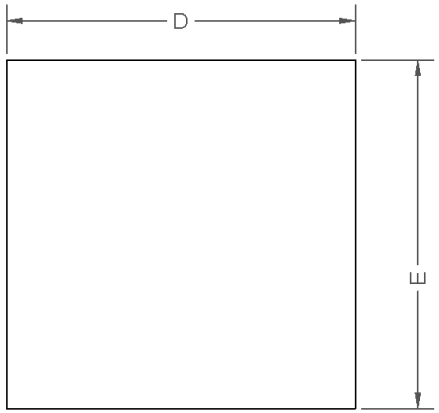
GaN Design Resources

The complete technical library of GaN design tools can be found at Renesasusa.com/design:

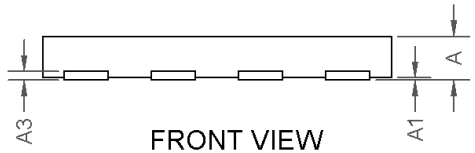
- Evaluation kits
- Application notes
- Design guides
- Simulation models
- Technical papers and presentations

Mechanical

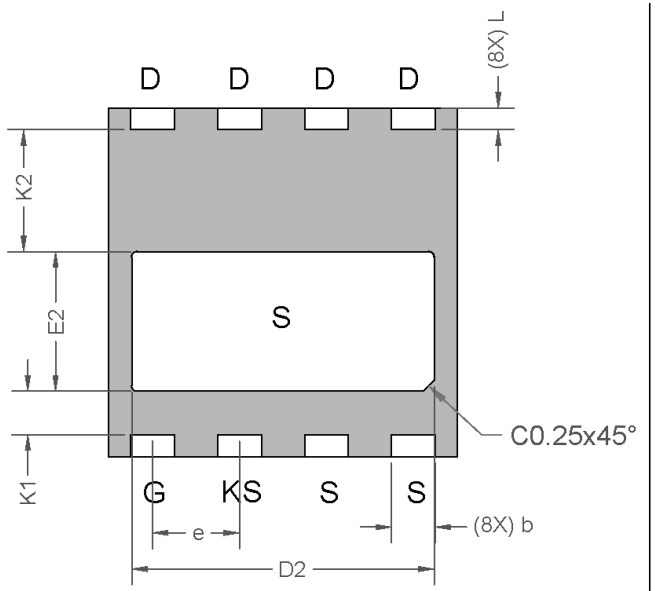
8x8 PQFN Package



TOP VIEW



FRONT VIEW



BOTTOM VIEW

G: Gate
S: Source
D: Drain
K: Kelvin
Lead finish: Sn plating

DIM	mm			inch		
	MIN	NOM	MAX	MIN	NOM	MAX
A	0.90	1.00	1.10	0.035	0.039	0.043
A1	0.00	-	0.05	0.000	-	0.002
A3		0.20 REF.			0.007 BSC	
b	0.5	1.00	1.5	0.020	0.039	0.059
D	7.90	8.00	8.10	0.311	0.315	0.319
D2	6.79	6.94	7.09	0.267	0.273	0.279
E	7.90	8.00	8.10	0.311	0.315	0.319
e		2.00 BSC			0.007 BSC	
E2	3.05	3.20	3.35	0.120	0.126	0.132
K1	1.00	-	-	0.039	-	-
K2	2.8	-	-	0.110	-	-
L	0.40	0.50	0.60	0.016	0.020	0.024

PQFN 8mm x 8mm POD (TP65HxxxG4LSGB)

transphorm

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